

Notice of References Cited	Application/Control No. 10/051,976	Applicant(s)/Patent Under Reexamination HEI ET AL.	
	Examiner David M. Naff	Art Unit 1651	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,634,604	01-1987	Tlustakova et al.	427/213.33
	B	US-4,725,355	02-1988	Yamamoto et al.	210/266
	C	US-5,789,601	08-1998	Park et al.	549/283
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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